Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/653,824	WILKIE ET AL.	
Examiner	Art Unit	
Paul D. Kim	3720	

	SEARCHED				
Class	Subclass	Date	Examiner		
29	25.35 594 595 609.1	7/19/2005	PK		
156	222 299				
	300 301				
310	334 336				
	357 358				
	366 367				
427	96 100	$\downarrow$			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		
Reviewed Parent Application 09/430,677	7/19/2005	PK		
Text Search EAST/NPL (IEEE)	7/19/2005	PK		
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